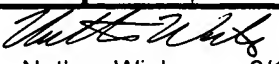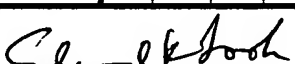| *Issue Classification*	Application/Control No. 10/517,143	Applicant(s)/Patent under Reexamination HIGASHIDA, MASASHITO
(barcode)	Examiner Nathan Wiehe	Art Unit 3745

ISSUE CLASSIFICATION

ORIGINAL		INTERNATIONAL CLASSIFICATION					
CLASS	**SUBCLASS**	**CLAIMED**					**NON-CLAIMED**
415	204	F	04	D	29	/44	/

CROSS REFERENCES		F	04	D	29	/28	/
CLASS	**SUBCLASS (ONE SUBCLASS PER BLOCK)**						
415	228					/	/
						/	/
						/	/
						/	/
						/	/.

Nathan Wiehe 9/18/06 (Assistant Examiner) (Date)	*Edward K Look* EDWARD K. LOOK SUPERVISORY PATENT EXAMINER (TECHNOLOGY CENTER 3700) 9/21/06	**Total Claims Allowed: 23**	
(Legal Instruments Examiner) (Date)		O.G. Print Claim(s) 1	O.G. Print Fig. 3

| ☐ Claims renumbered in the same order as presented by applicant | ☐ CPA | ☐ T.D. | ☐ R.1.47 |

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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16	5		35		65		95		125		155		185
2	6		36		66		96		126		156		186
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	28		58		88		118		148		178		208
	29		59		89		119		149		179		209
	30		60		90		120		150		180		210